AMENDMENTS TO THE CLAIMS

The following listing of claims will replace all prior versions of claims in the application.

- (currently amended) An apparatus for modifying the surface of a semiconductor wafer, said apparatus comprising
 - a textured, three-dimensional, fixed abrasive element comprising a plurality of abrasive particles;
 - b) a resilient element; and
 - a rigid element, said rigid element comprising
 - a plurality of rigid segments disposed between said fixed abrasive element and said resilient element, and
 - a plurality of grooves, wherein each rigid segment is spaced apart by at least one groove.
 - 2. (canceled)
 - (canceled)
- (original) The apparatus of claim 1, wherein said fixed abrasive element is bonded to said rigid segments.
- (original) The apparatus of claim 1, wherein said rigid segments are bonded to said resilient element.
- (original) The apparatus of claim 1, wherein said fixed abrasive element is capable
 of moving relative to said rigid segments.

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 (original) The apparatus of claim 1, wherein said fixed abrasive element and said rigid segments are capable of moving relative to said resilient element.

- 8, (original) The apparatus of claim 1, further comprising
 - a first web comprising said fixed abrasive element;
 - b. a second web comprising said plurality of rigid segments; and
 - a third web comprising said resilient element.
- (original) The apparatus of claim 8, wherein said first web and said second web are movable relative to each other.
- (original) The apparatus of claim 8, wherein said second web and said third web are movable relative to each other.
- (original) The apparatus of claim 8, wherein said first web and said third web are movable relative to each other.
- (original) The apparatus of claim 8, wherein said first web, said second web and said third web are movable relative to each other.
- 13. (previously presented) The apparatus of claim 1, further comprising a web comprising said plurality of rigid segments, said plurality of rigid segments comprising:
 - a first region comprising a first plurality of rigid segments having a first cross-sectional area; and
 - a second region comprising a second plurality of rigid segments having a second cross-sectional area,
 - said first cross-sectional area being different from said second crosssectional area.

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14. (previously presented) The apparatus of claim 1, wherein said plurality of rigid segments comprise a material selected from the group consisting of metal and plastic.

- (previously presented) A method of modifying the surface of a semiconductor wafer, said method comprising:
 - contacting the apparatus of claim 1 with a semiconductor wafer; and
 - b) moving said semiconductor wafer and said apparatus relative to each other.
 - 16. (previously presented) A method of modifying the surface of a semiconductor wafer comprising:
 - a) contacting the fixed abrasive element of the apparatus of claim 13 at a position proximate the first region with a semiconductor wafer;
 - b) moving said semiconductor wafer and said apparatus relative to each other;
 - c) contacting the fixed abrasive element of the apparatus of claim 13 at a
 position proximate the second region with the semiconductor wafer; and
 - d) moving said semiconductor wafer and said apparatus of claim 13 relative to each other.
- (previously presented) The method of claim 16, wherein said method further comprises indexing said web from a first position to a second position.